


<b>Search Notes</b> 	<b>Application/Control No.</b> 10553339	<b>Applicant(s)/Patent Under Reexamination</b> CHUNG, HAE IL
	<b>Examiner</b> McPartlin, Sarah B	<b>Art Unit</b> 3636

SEARCHED			
Class	Subclass	Date	Examiner
297	391, 406, 407, 408, 216.12	4/16/07	SBM

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with Peter Brown regarding search in cl. 297	4/16/07	SBM
Inventor search (eDAN)	4/16/07	SBM
Databases searched: US-PGPUBS; US-PAT; EPO; JPO; Derwent	4/16/07	SBM

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner